## Applicant(s)/Patent Under Reexamination Application/Control No. 10/619,974 CHAO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tuan C To 3663

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0236818	12-2003	Bruner et al.	709/200
*	В	US-2003/0187573	10-2003	Agnew et al.	701/201
*	С	US-2003/0083807	05-2003	Kuroda et al.	701/202
*	D	US-2003/0033083	02-2003	Nakashima et al.	701/211
*	E	US-2001/0037305	11-2001	Mochizuki, Yoshiyuki	705/52
*	F	US-2001/0029425	10-2001	Myr, David	701/200
	G	US-			
	H	US-			
	-	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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